

**Search Notes**

Application/Control No.

10/530,135

Examiner

Shih-Chao Chen

Applicant(s)/Patent under  
Reexamination

MIKAMI ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	789, 792.5, 866, 867	11/5/2006	CHEN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (See attached printout).	11/5/2006	CHEN